

<b>Notice of References Cited</b>	Application/Control No. 10/757,252	Applicant(s)/Patent Under Reexamination EPPICH ET AL.	
	Examiner Jesse A. Fenty	Art Unit 2815	Page 1 of 1

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	B	US-2002/0153573 A1	10-2002	Mogami, Tohru	257/369
	C	US-			
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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